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N-channel TrenchMOS standard level FET

Rev. 02 — 25 February 2010

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

#### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for high frequency applications due to fast switching characteristics

Switched-mode power supplies

#### **1.3 Applications**

DC-to-DC convertors

### 1.4 Quick reference data

Table 1. **Quick reference** Symbol Parameter Conditions Min Тур Max Unit drain-source voltage  $V_{DS}$ T<sub>j</sub> ≥ 25 °C; T<sub>j</sub> ≤ 175 °C -100 V -T<sub>mb</sub> = 25 °C; V<sub>GS</sub> = 10 V; 47 А  $I_{D}$ drain current \_ see Figure 1 and 2 T<sub>mb</sub> = 25 °C; see Figure 3 W P<sub>tot</sub> total power 166 -dissipation **Dynamic characteristics** gate-drain charge  $V_{GS} = 10 \text{ V}; I_D = 40 \text{ A};$ 21 nC Q<sub>GD</sub> \_ V<sub>DS</sub> = 80 V; T<sub>i</sub> = 25 °C; see Figure 13 **Static characteristics** R<sub>DSon</sub> drain-source  $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ 20 28 mΩ on-state resistance T<sub>i</sub> = 25 °C; see Figure 11 and 12



N-channel TrenchMOS standard level FET

### 2. Pinning information

Table 2.	Pinning	information					
Pin	Symbol	Description		Simplified outline	Graphic symbol		
1	G	gate		_	_		
2	D	drain	<u>[1]</u>	mb			
3	S	source					
mb	D	mounting base; connected to drain			mbb076 S		
				SOT404 (D2PAK)			

[1] It is not possible to make a connection to pin 2.

### 3. Ordering information

#### Table 3.Ordering information

Type number	Package					
	Name	Description	Version			
PHB47NQ10T	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404			

N-channel TrenchMOS standard level FET

### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		<b>3911</b>			
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	100	V
V <sub>DGR</sub>	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	100	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	$V_{GS}$ = 10 V; $T_{mb}$ = 100 °C; see <u>Figure 1</u>	-	33	А
		$V_{GS}$ = 10 V; $T_{mb}$ = 25 °C; see <u>Figure 1</u> and <u>2</u>	-	47	А
I <sub>DM</sub>	peak drain current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$ ; see Figure 2	-	187	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 3</u>	-	166	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-dr	ain diode				
Is	source current	T <sub>mb</sub> = 25 °C	-	47	А
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	187	А
Avalanche	e ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche	$V_{GS} = 5$ V; $T_{j(init)} = 25$ °C; $I_D = 30$ A; $V_{sup} \le 25$ V; unclamped; $t_p = 0.1$ ms; $R_{GS} = 50$ Ω; see Figure 4	-	45	mJ

energy

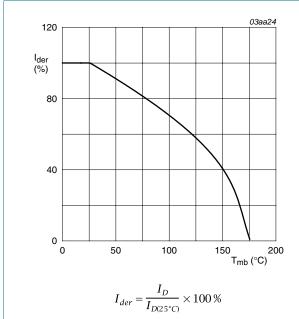
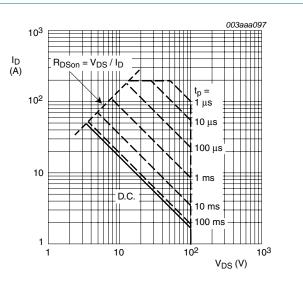
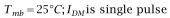


Fig 1. Normalized continuous drain current as a function of mounting base temperature



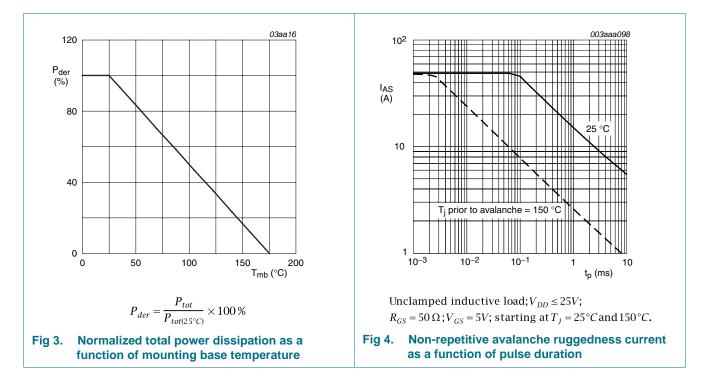




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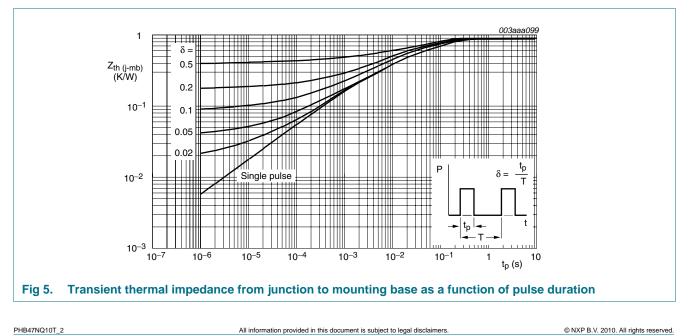
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#### 5. **Thermal characteristics**

#### Table 5. **Thermal characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	-	0.9	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	50	-	K/W
	junction to ambient					



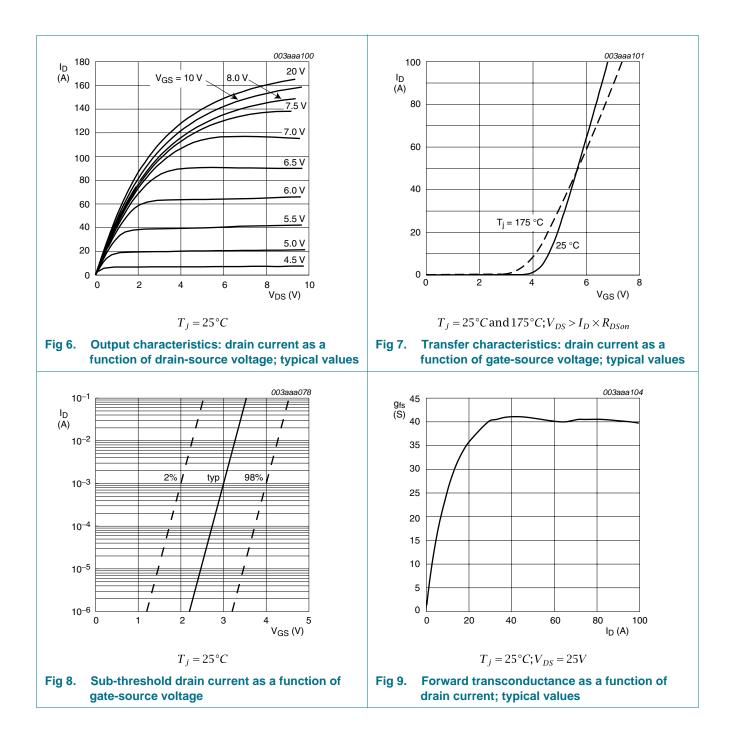
4 of 13

N-channel TrenchMOS standard level FET

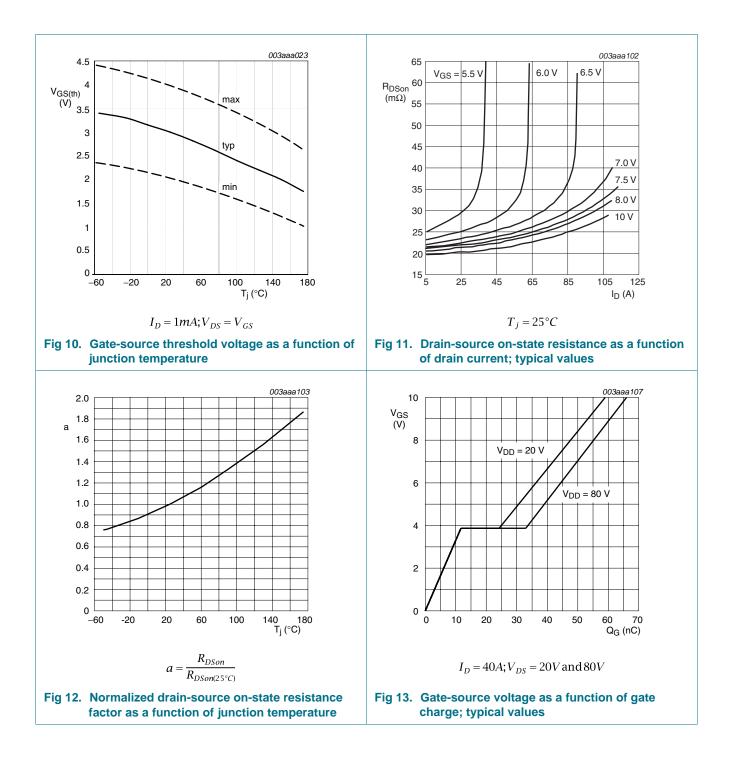
### 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ\text{C}$	100	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; see <u>Figure 10</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 10	2	3	4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μA
		$V_{DS}$ = 100 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C	-	-	500	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 175 °C; see <u>Figure 11</u> and <u>12</u>	-	-	76	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C; see <u>Figure 11</u> and <u>12</u>	-	20	28	mΩ
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 40 \text{ A}; V_{DS} = 80 \text{ V}; V_{GS} = 10 \text{ V};$	-	66	-	nC
Q <sub>GS</sub>	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 13}{13}$	-	12	-	nC
Q <sub>GD</sub>	gate-drain charge		-	21	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2320	3100	pF
C <sub>oss</sub>	output capacitance	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 14}{14}$	-	315	378	pF
C <sub>rss</sub>	reverse transfer capacitance		-	187	256	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	15	23	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \ \Omega; \ T_j = 25 \ ^{\circ}C$	-	70	105	ns
t <sub>d(off)</sub>	turn-off delay time		-	83	116	ns
t <sub>f</sub>	fall time		-	45	63	ns
Source-d	rain diode					
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; see <u>Figure 15</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S} = 47 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = -10 \text{ V};$	-	66	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 30 V; T <sub>j</sub> = 25 °C	-	0.24	-	μC

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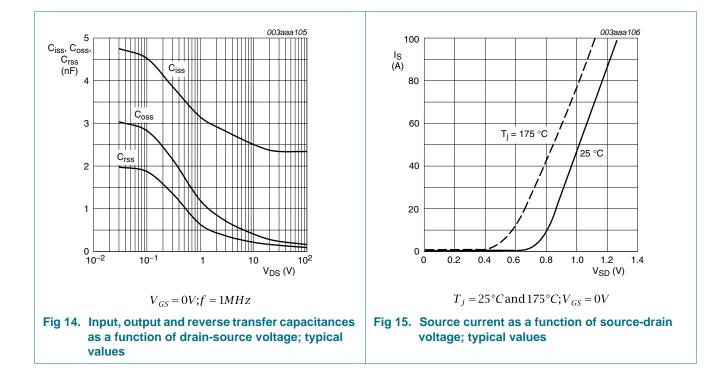
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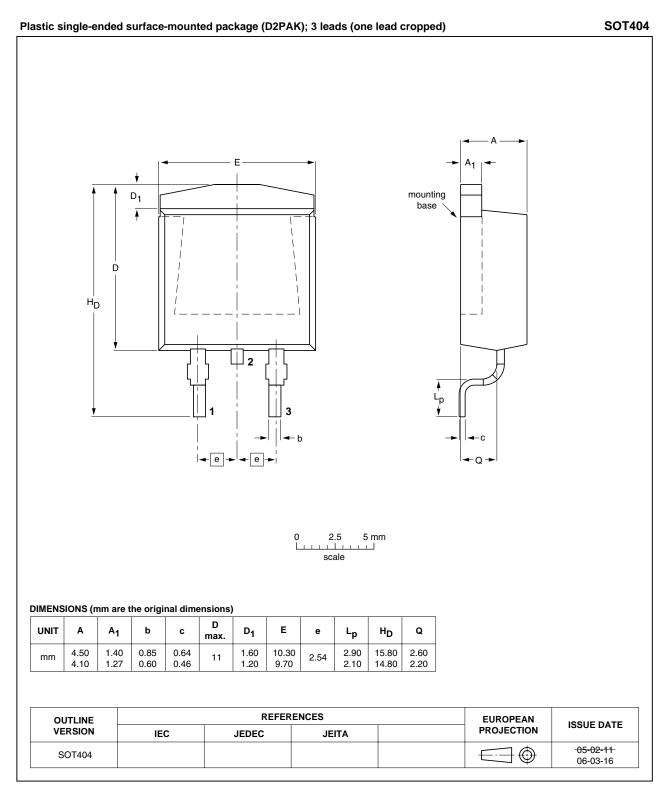
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### 7. Package outline



#### Fig 16. Package outline SOT404 (D2PAK)

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PHB47NQ10T\_2

#### N-channel TrenchMOS standard level FET

### 8. Revision history

Table 7. Revision histo	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PHB47NQ10T_2	20100225	Product data sheet	-	PHP_PHB_47NQ10T-01
Modifications:	guidelines o	of this data sheet has been of NXP Semiconductors. have been adapted to the		
PHP_PHB_47NQ10T-01 (9397 750 08243)	20010516	Product data	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[2] The term 'short data sheet' is explained in section "Definitions".

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#### N-channel TrenchMOS standard level FET

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#### N-channel TrenchMOS standard level FET

### **11. Contents**

1	Product profile1
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values
5	Thermal characteristics4
6	Characteristics5
7	Package outline9
8	Revision history10
9	Legal information11
9.1	Data sheet status11
9.2	Definitions11
9.3	Disclaimers
9.4	Trademarks12
10	Contact information12

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